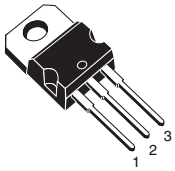
STP75NS04Z

N-channel Clamped - 7mΩ - 80A - TO-220
Fully protected MESH Overlay™ III Power MOSFET

General features

Type	V_{DSS}	$R_{DS(on)}$	I_D
STP75NS04Z	Clamped	< 11mΩ	80A

- Low capacitance and gate charge
- 100% avalanche tested
- 175°C maximum junction temperature

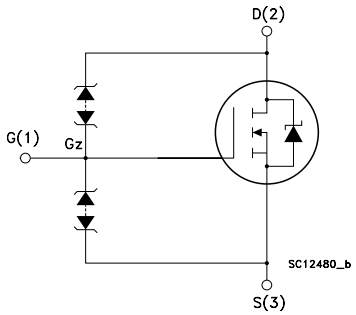


TO-220

Description

This fully clamped MOSFET is produced by using the latest advanced Company's Mesh Overlay process which is based on a novel strip layout. The inherent benefits of a new technology coupled with the extra clamping capabilities make this product particularly suitable for the harshest operation conditions such as those encoured in power tools. Any other application requiring extra ruggedness is also recommended.

Internal schematic diagram



Applications

- Switching application
- Power tools

Order codes

Part number	Marking	Package	Packaging
STP75NS04Z	P75NS04Z	TO-220	Tube

Contents

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage (V_{GS} = 0)	Clamped	V
V_{DG}	Drain-gate voltage (V_{GS} = 0)	Clamped	V
V_{GS}	Gate-source voltage	Clamped	V
I_D(1)	Drain current (continuous) at T_C = 25°C	80	A
I_D	Drain current (continuous) at T_C = 100°C	63	A
I_{DG}	Drain gate current (continuos)	±50	mA
I_{GS}	Gate source current (continuos)	±50	mA
I_{DM}(2)	Drain current (pulsed)	320	A
P_{TOT}	Total dissipation at T_C = 25°C	110	W
	Derating factor	0.73	W/°C
V_{ESD}	Gate-source ESD (HBM-C=100pF, R=1.5KΩ)	±8	kV
T_j T_{stg}	Operating junction temperature Storage temperature	-55 to 175	°C

1. Current limited by wire bonding
2. Pulse with limited by safe operating area

Table 2. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj\text{-}case}$	Thermal resistance junction-case Max	1.36	°C/W
$R_{thj\text{-}amb}$	Thermal resistance junction-ambient Max	62.5	°C/W
T_l	Maximum lead temperature for soldering purpose	300	°C

Table 3. Avalanche data

Symbol	Parameter	Value	Unit
E_{AS}	Single pulse avalanche energy (starting Tj=25°C, I_D=I_{AR}, V_{DD}=25V)	470	mJ

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test condictions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	I_D = 1mA, V_{GS}= 0	33			V
I_{DSS}	Zero gate voltage drain current (V_{GS} = 0)	V_{DS} = 16V			1	µA
I_{GSS}	Gate body leakage current (V_{DS} = 0)	V_{GS} = ±10V			2	µA
V_{GSS}	Gate threshold breakdown voltage	I_{GS}= ±100µA	18			V
$V_{GS(th)}$	Gate threshold voltage	V_{DS}= V_{GS}, I_D = 250µA	2	3	4	V
$R_{DS(on)}$	Static drain-source on resistance	V_{GS}= 10V, I_D= 40A		7	11	mΩ

Table 5. Dynamic

Symbol	Parameter	Test condictions	Min.	Typ.	Max.	Unit
g_{fs} (1)	Forward transconductance	V_{DS} =15V, I_D = 15A		50		S
C_{iss} C_{oss} C_{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V_{DS} = 25V, f = 1 MHz, V_{GS} =0		1860 628 196		pF pF pF
Q_g Q_{gs} Q_{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD}= 20V, I_D= 80 A, V_{GS}= 10 V *(see Figure 13)*		50 14 16		nC nC nC

1. Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 6. Switching on/off

Symbol	Parameter	Test condictions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r	Turn-on delay time Rise time	V_{DD}= 20V, I_D = 40A R_G= 4.7 Ω, V_{GS}= 10V, *(see Figure 12)*		16 248		ns ns
$t_{d(off)}$ t_f	Turn-off delay time Fall time	V_{DD}= 20V, I_D = 40A R_G= 4.7 Ω, V_{GS}= 10V, *(see Figure 12)*		53 85		ns ns

Table 7. Source drain diode

Symbol	Parameter	Test condictions	Min.	Typ.	Max.	Unit
I_{SD} I_{SDM}(1)	Source-drain current Source-drain current (pulsed)				80 320	A A
V_{SD}(2)	Forward on Voltage	I_{SD}=80A, V_{GS}=0			1.5	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD}=80A, di/dt = 100A/µs, V_{DD}=30V, Tj=150°C *(see Figure 17)*		53 91 3.4		ns nC A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration=300µs, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

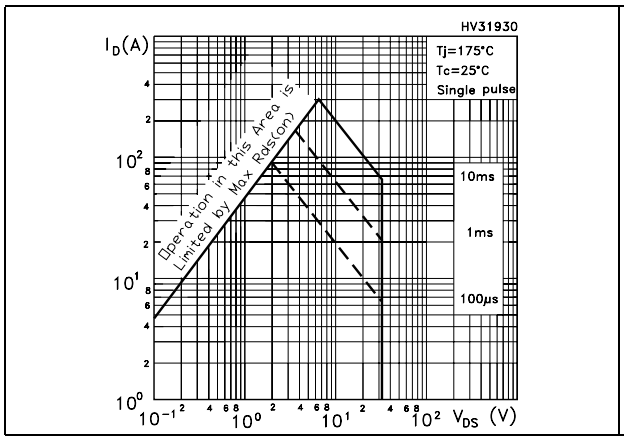


Figure 2. Thermal impedance

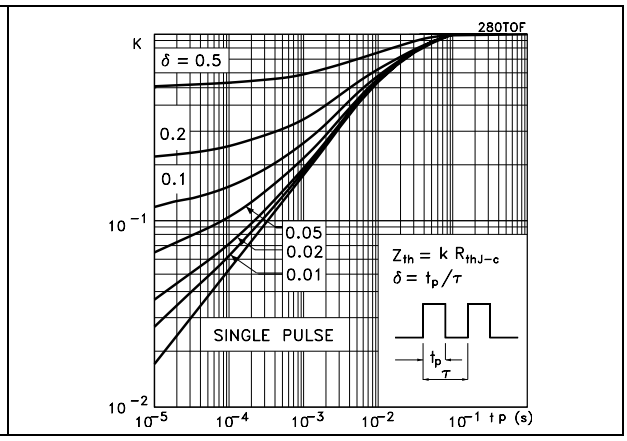


Figure 3. Output characterisics

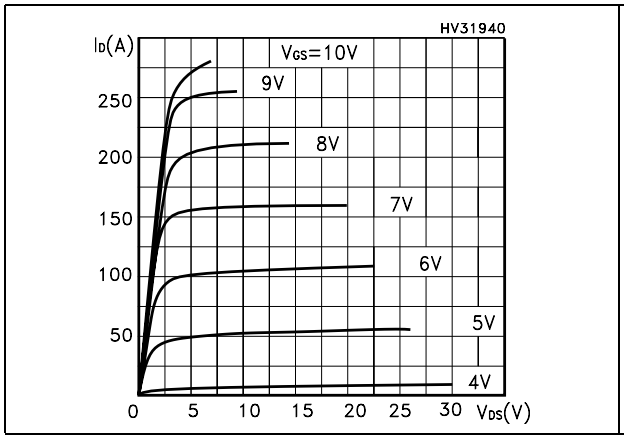


Figure 4. Transfer characteristics

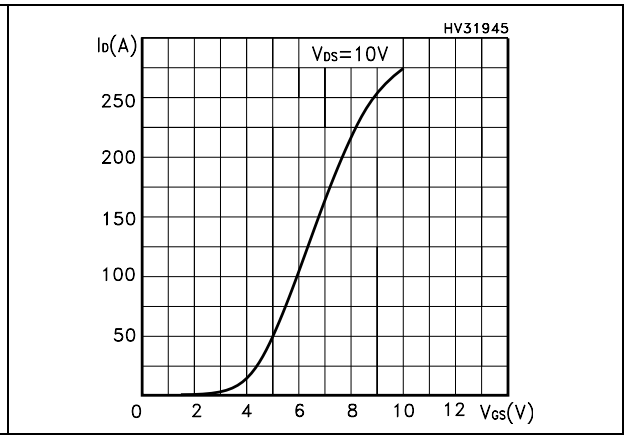


Figure 5. Normalized B_{VDSS} vs temperature

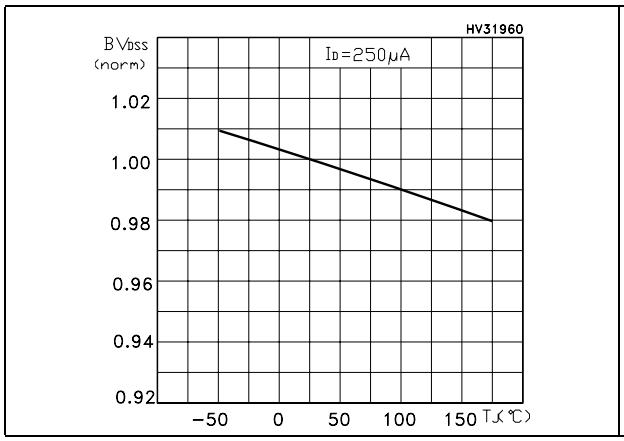


Figure 6. Static drain-source on resistance

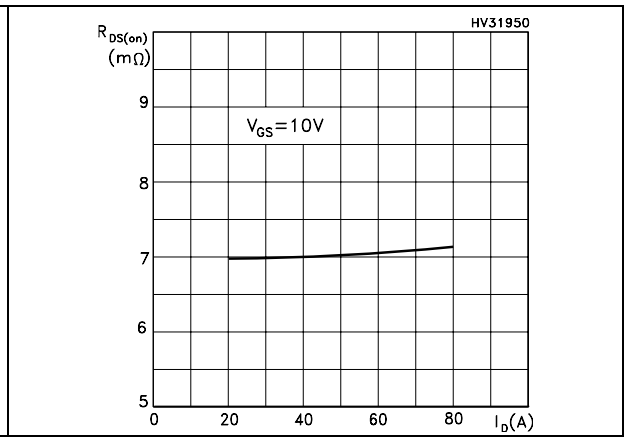


Figure 7. Gate charge vs gate-source voltage

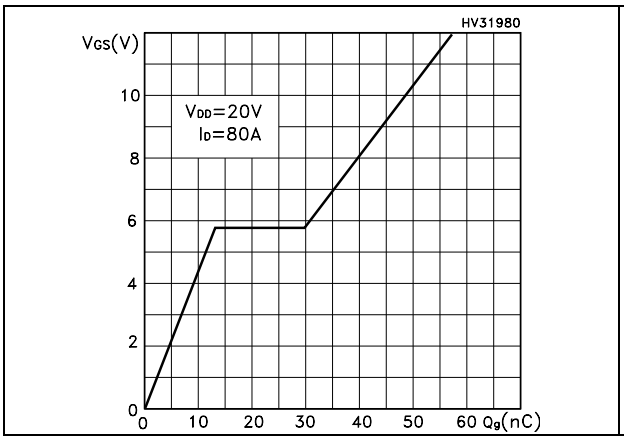


Figure 8. Capacitance variations

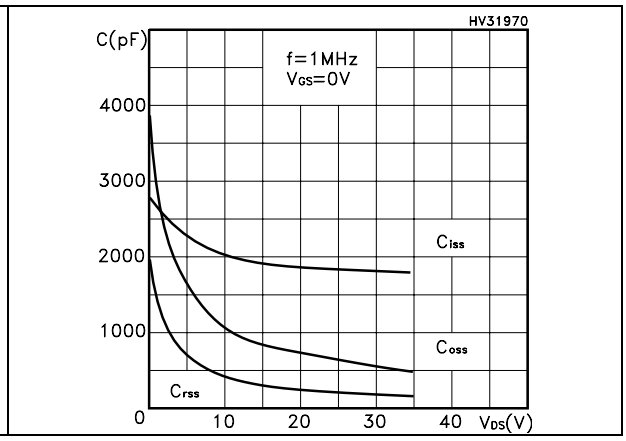


Figure 9. Normalized gate threshold voltage vs temperature

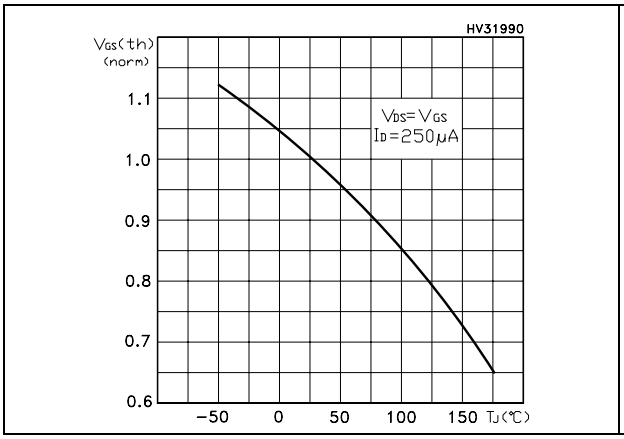


Figure 10. Normalized on resistance vs temperature

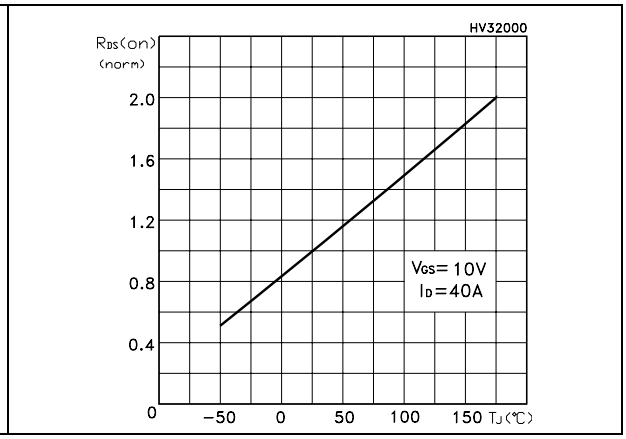
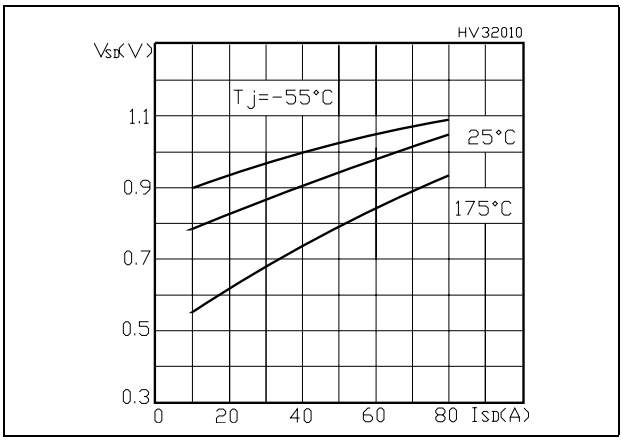


Figure 11. Source-drain diode forward characteristics



3 Test circuit

Figure 12. Switching times test circuit for resistive load

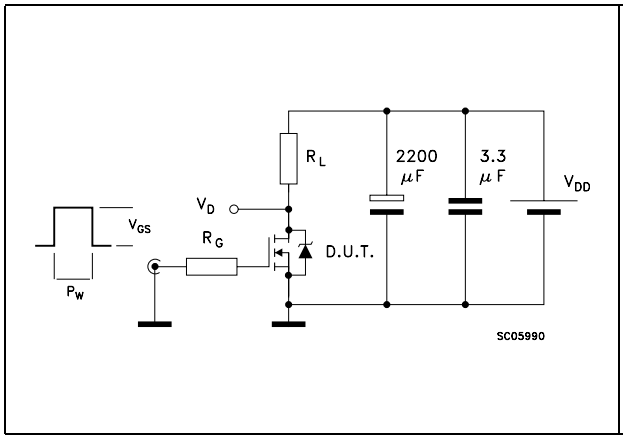


Figure 13. Gate charge test circuit

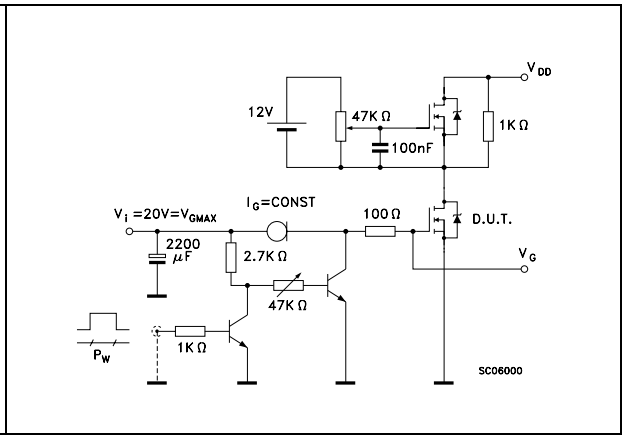


Figure 14. Test circuit for inductive load switching and diode recovery times

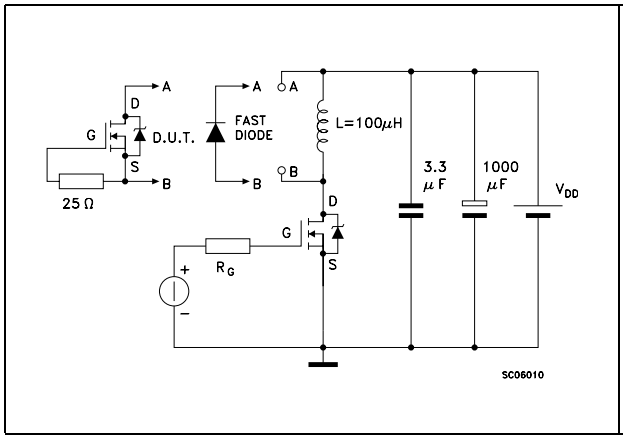


Figure 15. Unclamped inductive load test circuit

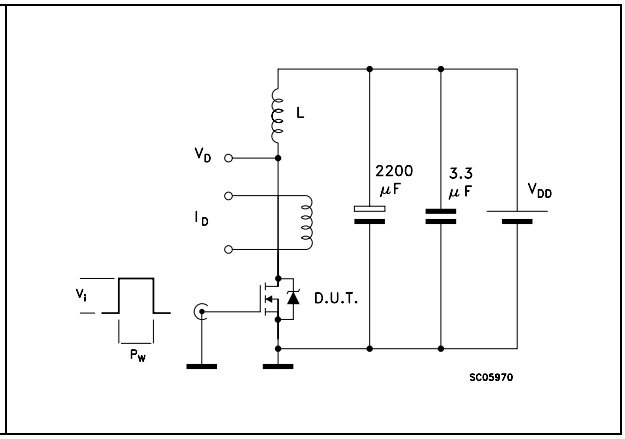


Figure 16. Unclamped inductive waveform

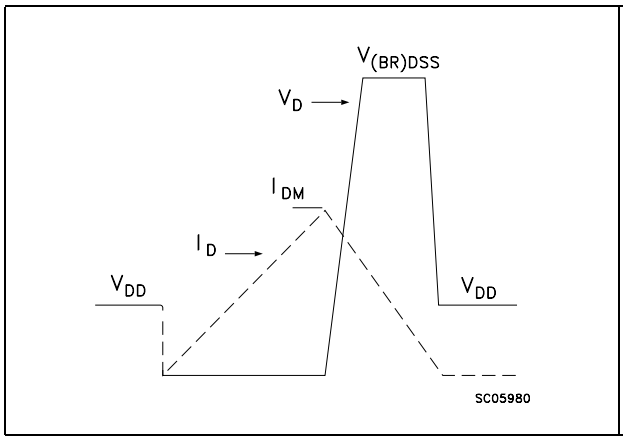
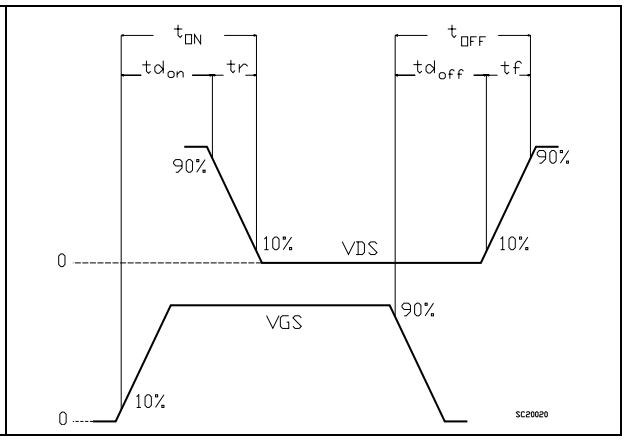


Figure 17. Switching time waveform

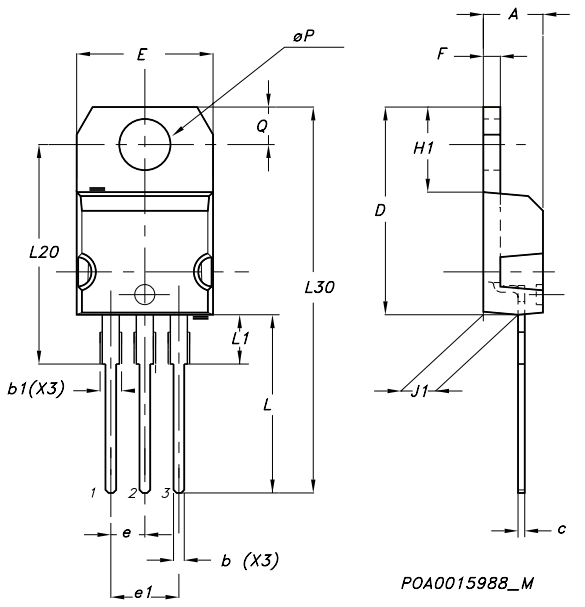


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com*

TO-220 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
c	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
E	10		10.40	0.393		0.409
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



5 Revision history

Table 8. Revision history

Date	Revision	Changes
06-Jun-2006	1	First release

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